

Search Notes

Application/Control No.

10/624,404

Examiner

Mark A. Mais

Applicant(s)/Patent under
Reexamination

CROUCH ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	351-360	3/4/2007	MAM
	373		
	384		
	385		
	395.6		
	401		
	410		
	426		
	464		
	465		
	466		
	467		
	522		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See Attached Electronic Search	3/4/2007	MAM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner